



IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Examiner: Vincent Q. Nguyen Eaton Case No. 01-EDP-450

Applicant(s): David M. Tallman et al.

Serial No.: 10/090,991 Group Art Unit 2858

Filed: March 5, 2002 In Response to Paper No. 2

Title: Testing Device for Detecting and Locating Arc Faults in an Electrical System

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September 18, 2003

Commissioner of Patents and Trademarks
Washington, DC 20231

SIR:

In response to the Office Action June 19, 2003, please amend the above- identified application as follows:

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